

**Microsemi Corp.**  
The diode experts

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# 1N4890 thru 1N4895 and 1N4890A thru 1N4895A WITH CERTIFIED ZENER VOLTAGE STABILITY

## DESCRIPTION

This series of Microsemi 400mW Ultra-Stable Reference Diodes offers a **CERTIFIED REFERENCE VOLTAGE STABILITY** as measured over an actual operating period of 1000 hours. Standard stabilities are 10, 20, and 50 PPM/1000 hours. Units having stabilities of less than 5 PPM/1000 hours are available on special request.

Ultra-Stable Certified Reference Diodes, available in standard or radiation hardened construction, can be used in any circuit that requires a stable reference voltage that is insensitive to shock, vibration, or position. Their inherent stability allows them to be used in circuits requiring an extremely high degree of voltage time stability such as those in Digital Voltmeters, Computers, X-Y Recorders, Missile Guidance and Environmental Control Systems, and Portable Reference Standards. Wherever accurate and reliable measurements are to be made, the Microsemi "Ultra-Stable" diode excels as the Standard Reference device.

All devices in this series have been subjected to Microsemi's 1000 hour Stability Test Sequence, consisting of a 1000 hour power age with reference voltage measured once every 168 hours giving a total of 7 individual test points. The stability test is performed at  $80^{\circ}\text{C} \pm 0.1^{\circ}\text{C}$ .

A Certificate containing the following data is supplied with each diode:

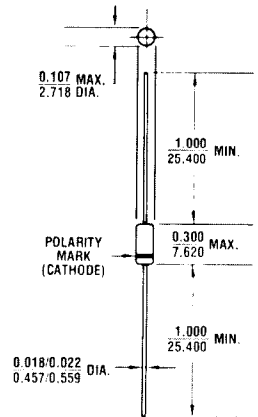
1. The stability test voltage readings.
2. The voltage drift as referenced to "Zero Hour" in both  $\mu\text{V}$  and in PPM (Parts-Per-Million).

To certify these diodes to such tight stabilities as 10 PPM/1000 hours, every factor of environment, both ambient and electrical is considered and controlled to "Standards Laboratory" accuracy.

To specify radiation hardened devices, use "RH" prefix instead of "1N", i.e. RH4895A instead of 1N4895A.

Consult factory for TX, TXV or JANS equivalent SCDs.

## 6.35 VOLT ULTRA STABLE TEMPERATURE COMPENSATED ZENER REFERENCE DIODES



All dimensions in  $\frac{\text{INCH}}{\text{m.m.}}$

FIGURE 1

## MECHANICAL CHARACTERISTICS

**CASE:** Hermetically sealed glass case.  
DO-7 (DO-204AA).

**FINISH:** All external surfaces are corrosion resistant and leads solderable.

**THERMAL RESISTANCE:**  $300^{\circ}\text{C}/\text{W}$  (Typical) junction to lead at 0.375-inches from body.

**POLARITY:** Diode to be operated with the banded end positive with respect to the opposite end.

**WEIGHT:** 0.2 grams.

**MOUNTING POSITION:** Any

## 6.35 VOLT ULTRA-STABLE (T. C.) ZENER REFERENCE DIODES

### MAXIMUM RATINGS (See Fig. 5)

Operating Temperature Range:  $-65^{\circ}\text{C}$  to  $+175^{\circ}\text{C}$   
 Maximum Lead Temperature  $1/16 \pm 1/32$  inch from case for 10 seconds:  $230^{\circ}\text{C}$   
 Maximum DC Power Dissipation at or below  $50^{\circ}\text{C}$  Ambient: 400 mW  
 Linear Derating:  $3.2 \text{ mW}/^{\circ}\text{C}$  (See Figure 5)  
 Maximum Steady State Current ( $I_{ZT}$ ) at  $150^{\circ}\text{C}$ : 7.5 mA

### MECHANICAL CHARACTERISTICS

Case: Hermetically sealed glass  
 Dimensions: DO-7 outline  
 Finish: All external surfaces are corrosion resistant and leads are readily solderable  
 Polarity: Diode to be operated with the banded end positive  
 Weight: 0.2 grams (typical)  
 Mounting Position: Any

\*ELECTRICAL CHARACTERISTICS @  $25^{\circ}\text{C}$ , unless otherwise specified

JEDEC TYPE NUMBER	NOMINAL ZENER VOLTAGE $\pm 5\%$ $V_Z @ I_{ZT}$	ZENER TEST CURRENT $\pm 0.01 \text{ mA}$ $I_{ZT}$	MAXIMUM ZENER IMPEDANCE $Z_{ZT} @ I_{ZT}$ (NOTE 1)	VOLTAGE TEMPERATURE STABILITY $\Delta V_{ZT}$ MAXIMUM (NOTE 2)	TEMPERATURE RANGE	EFFECTIVE TEMPERATURE COEFFICIENT $\alpha_{VZ}$	VOLTAGE TIME STABILITY @ $80^{\circ}\text{C}$ INITIAL-TO PEAK $\Delta V_{ZT}$ MAXIMUM (NOTE 3)	EFFECTIVE VOLTAGE TIME STABILITY INITIAL-TO-PEAK
	VOLTS	mA	OHMS	mV			$^{\circ}\text{C}$	
1N4890	6.35	7.5	10	5.0	25 to 100	0.001	318	50
1N4890A	6.35	7.5	10	10.0	$-55$ to 100	0.001	318	50
1N4891	6.35	7.5	10	2.5	25 to 100	0.0005	318	50
1N4891A	6.35	7.5	10	5.0	$-55$ to 100	0.0005	318	50
1N4892	6.35	7.5	10	5.0	25 to 100	0.001	127	20
1N4892A	6.35	7.5	10	10.0	$-55$ to 100	0.001	127	20
1N4893	6.35	7.5	10	2.5	25 to 100	0.0005	127	20
1N4893A	6.35	7.5	10	5.0	$-55$ to 100	0.0005	127	20
1N4894	6.35	7.5	10	5.0	25 to 100	0.001	64	10
1N4894A	6.35	7.5	10	10.0	$-55$ to 100	0.001	64	10
1N4895	6.35	7.5	10	2.5	25 to 100	0.0005	64	10
1N4895A	6.35	7.5	10	5.0	$-55$ to 100	0.0005	64	10

#### NOTE 1

The zener impedance is derived from the 60 Hz ac voltage which results when an ac current having an rms value equal to 10% of the DC zener current ( $I_{ZT}$ ) is superimposed on  $I_{ZT}$ .

#### NOTE 2

Maximum allowable change observed over the entire temperature range i.e., the diode voltage will not exceed the specified mV change at any discrete temperature between the established limits.

#### NOTE 3

When operated at:  
 $I_{ZT} = 7.5 \text{ mA} \pm 0.0001 \text{ mA}$   
 $T_A = 80^{\circ}\text{C} \pm 0.1^{\circ}\text{C}$   
 (See Note 2 Below)

## NOTES AND PRECAUTIONS FOR CERTIFIED REFERENCE DIODES

**1. DIODE IDENTIFICATION:** The diodes are shipped attached to their certification papers and each diode is individually packaged with the diode identification on the package. Identification includes JEDEC type number and a diode serial number consisting of 7 digits showing the lot number and diode number, which provide traceability to factory records.

**2. PRECAUTIONS:** The normal precautions must be taken when soldering as with any semiconductor device, such as a thermal shunt between the

soldering iron and the diode body. "Mechanical" rather than solder mounting is preferred for optimum performance. Mounting the diode inside a large thermal mass such as aluminum, copper, brass, or epoxy will reduce thermally induced voltage fluctuations discernible as low frequency noise in the 0-3 Hz region of the spectrum.

Certain precautions must be taken to ensure that the diode's stability is fully utilized in the circuit. If the current through the zener is not controlled, the refer-

## 6.35 VOLT ULTRA-STABLE (T. C.) ZENER REFERENCE DIODES

ence voltage will shift due to diode impedance ( $\Delta V_Z = \Delta I_Z \times Z_{ZT}$ ). If the diode's junction temperature is allowed to change, due to a change in ambient or case temperature or due to a power level change, a shift in voltage will occur consistent with the temperature coefficient of the diode. In addition, the device must be physically mounted so as to give the diode a constant thermal resistance, junction-to-ambient. Drafts, circulating oil, and even the minute convection currents produced by a diode in a closed container can cause shifts in reference voltage greater than those that can be attributed to the diode's inherent stability.

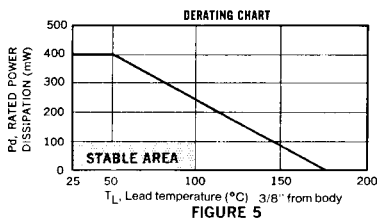
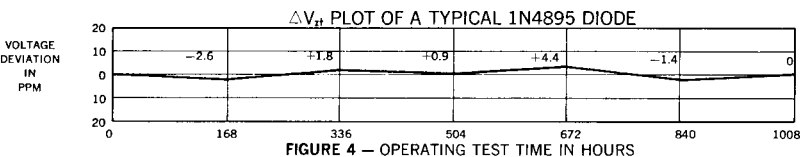
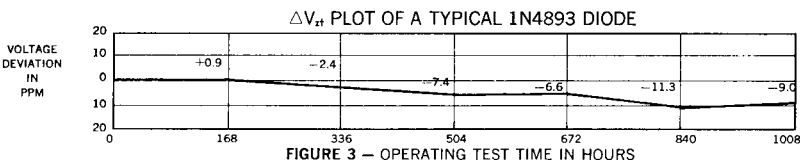
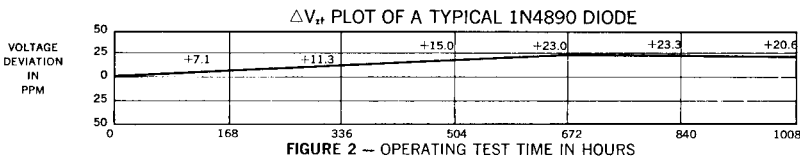
It *must* be understood that the certified stability is possible only under steady-state, constant temperature conditions. The stability of an ultra-stable zener reference diode may be upset by severe changes in junction temperature. In addition, a slight derating of voltage-time stability ( $\Delta V_{ZT}$ ) may be experienced if the diode is operated outside the "stable-area" defined in Figure 5. The effect of turning the diode's current off and on at a *constant* temperature is negligible (except for thermal warmup of diode). The certified stability of the diode is considered to be a worst case "inherent" junction stability, and will be realized only after 2 or 3 weeks of operation under *actual operating conditions*. This might be in the user's circuit or finished product, however, the device must have this time to reach an "equilibrium" at operating conditions. The "inherent" stability of the

device is never upset unless maximum ratings are surpassed. A new "equilibrium" must be reached with each new operating condition.

Temperature coefficients much lower than specified can be attained by operating the diode at "0" TC crossover current (the point at which TC goes from positive to negative or vice-versa), however, a new "equilibrium" must be reached before full stability will be attained.

**3. MICROSEMI TEST METHOD:** Microsemi uses a potentiometric method of zener voltage measurement on certified reference diodes. Zener voltage is measured to seven digits (1 microvolt resolution). Voltage calibration is directly traceable to the National Bureau of Standards. Oil bath temperature is controlled to better than  $0.1^\circ\text{C}$ , and current is constant and repeatable to better than  $\pm 0.1 \mu\text{A}$ . Test clips are designed for the four-terminal method of measurement (separate voltage and current connections) to eliminate errors caused by resistance. The diodes are thermally shielded by an aluminum thermal filter to reduce thermally created error causing voltage fluctuations.

**4. 1000 HOUR STABILITY TEST SEQUENCE:** Voltage is measured seven times during the test with the last six measurements referenced to the first. The measurements are taken 168 hours apart, giving a total test time of 1008 hours.

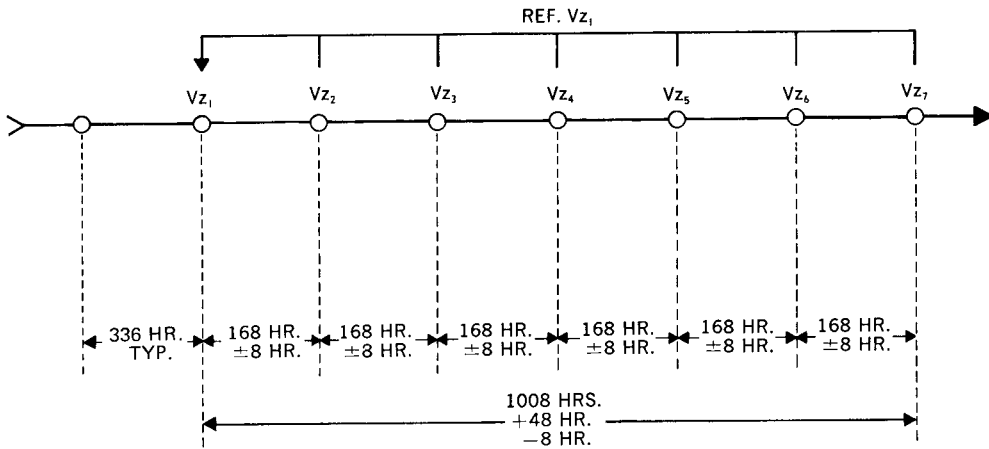


THE "STABLE AREA" IS DEFINED AS THE AREA IN WHICH THE MAXIMUM TIME STABILITY ( $\Delta V_{zt}$ ) IS ATTAINABLE.

A SLIGHT DERATING IN THE TIME STABILITY MAY BE EXPECTED IF THE DIODE IS OPERATED OUTSIDE THIS AREA.

# 6.35 VOLT ULTRA-STABLE (T. C.) ZENER REFERENCE DIODES

## 1000 HOUR STABILITY TEST SEQUENCE



### Notes:

Test Temperature . . . . .  $80^{\circ}\text{C} \pm 0.1^{\circ}\text{C}$

Test Current . . . . . 7.5 mA. with a constancy and repeatability of  $\pm 0.1$  microamp.

The first 336 hours of operation is a stabilization period. The stability of a diode is measured by the worst voltage difference ( $\Delta V_Z$ ) referenced to  $V_{z1}$ .